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Optics and photonics — Lasers and laser-related equipment — Cavity ring-down method for highreflectance and high-transmittance measurements

Optique et photonique — Lasers et équipement associé aux lasers — Méthode d'alternance de la cavité pour les mesurages du facteur de réflexion et du facteur de transmission

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Foreword Introduction Internation
1 Scope 1 2 Normative references 1 3 Terms and definitions 1 4 Symbols used and units of measure 2 5 Test principles 2 5.1 General 2 5.2 Decay time of initial cavity and reflectance of cavity mirrors 2 5.3 Decay time of test cavity and reflectance/transmittance of test sample 4 5.4 High reflectance/transmittance measurement with an optical feedback CRD technique 5 6 Preparation of test sample and measurement arrangement 6 6.1 Test sample 6 6.2 Laser source 6 6.3 Ring-down cavity 7 6.4 Detection unit 7 6.5 Data acquisition and processing 7 6.6 Environment 8 7 Test procedure 7 7.1 General 7 7.2 Measurement of decay time of initial cavity 7 7.3 Calculation of reflectance of cavity mirrors 7 7.4 Measurement of decay time of test cavity 7 7.5 Calculation of reflectance of test sample 9 7.6 Assessments of the measurement 9 8 Main error factors 8 8 Main error factors 10 8.1 Influence of the instrumental response time on reflectance/transmittance
2 Normative references
2 Normative references
Terms and definitions Symbols used and units of measure Test principles 5.1 General 5.2 Decay time of initial cavity and reflectance of cavity mirrors 5.3 Decay time of test cavity and reflectance/transmittance of test sample 5.4 High reflectance/transmittance measurement with an optical feedback CRD technique 5.4 High reflectance/transmittance measurement with an optical feedback CRD technique 6. Preparation of test sample and measurement arrangement 6.1 Test sample 6.2 Laser source 6.3 Ring-down cavity 6.4 Detection unit 6.5 Data acquisition and processing 6.6 Environment 7 Test procedure 7.1 General 7.2 Measurement of decay time of initial cavity 7.3 Calculation of reflectance of cavity mirrors 9. 7.4 Measurement of decay time of test cavity 7.5 Calculation of reflectance/transmittance of test sample 9. 7.6 Assessments of the measurement 8 Main error factors 8 Main error factors 10
4 Symbols used and units of measure
5Test principles25.1General25.2Decay time of initial cavity and reflectance of cavity mirrors25.3Decay time of test cavity and reflectance/transmittance of test sample45.4High reflectance/transmittance measurement with an optical feedback CRD technique56Preparation of test sample and measurement arrangement66.1Test sample66.2Laser source66.3Ring-down cavity76.4Detection unit76.5Data acquisition and processing76.6Environment87Test procedure87.1General87.2Measurement of decay time of initial cavity87.3Calculation of reflectance of cavity mirrors97.4Measurement of decay time of test cavity97.5Calculation of reflectance/transmittance of test sample97.6Assessments of the measurement98Main error factors108.1Influence of the instrumental response time on reflectance/transmittance
5.1 General 2 5.2 Decay time of initial cavity and reflectance of cavity mirrors 2 5.3 Decay time of test cavity and reflectance/transmittance of test sample 4 5.4 High reflectance/transmittance measurement with an optical feedback CRD technique 5 6 Preparation of test sample and measurement arrangement 6 6.1 Test sample 6 6.2 Laser source 6 6.3 Ring-down cavity 7 6.4 Detection unit 7 6.5 Data acquisition and processing 7 6.6 Environment 8 7 Test procedure 8 7.1 General 8 7.2 Measurement of decay time of initial cavity 8 7.3 Calculation of reflectance of cavity mirrors 9 7.4 Measurement of decay time of test cavity 7 7.5 Calculation of reflectance/transmittance of test sample 9 7.6 Assessments of the measurement 9 8 Main error factors 10 8.1 Influence of the instrumental response time on reflectance/transmittance
5.2 Decay time of initial cavity and reflectance of cavity mirrors 5.3 Decay time of test cavity and reflectance/transmittance of test sample 4.5.4 High reflectance/transmittance measurement with an optical feedback CRD technique 5.4 High reflectance/transmittance measurement with an optical feedback CRD technique 5.5 Preparation of test sample 6.1 Test sample 6.2 Laser source 6.3 Ring-down cavity 7.6.4 Detection unit 7.6.5 Data acquisition and processing 7.6.6 Environment 8.5 Data acquisition and processing 7.6.6 Environment 8.5 Test procedure 7.1 General 8.7.2 Measurement of decay time of initial cavity 7.3 Calculation of reflectance of cavity mirrors 7.4 Measurement of decay time of test cavity 7.5 Calculation of reflectance/transmittance of test sample 7.6 Assessments of the measurement 9.5 Main error factors 10.8 Main error factors 10.8 Main error factors 10.8 Influence of the instrumental response time on reflectance/transmittance
5.3 Decay time of test cavity and reflectance/transmittance of test sample 5.4 High reflectance/transmittance measurement with an optical feedback CRD technique 5.4 High reflectance/transmittance measurement with an optical feedback CRD technique 5.6 Preparation of test sample and measurement arrangement 6.1 Test sample 6.2 Laser source 6.3 Ring-down cavity 7.6.4 Detection unit 7.7 6.5 Data acquisition and processing 6.6 Environment 7.1 General 7.2 Measurement of decay time of initial cavity 7.3 Calculation of reflectance of cavity mirrors 7.4 Measurement of decay time of test cavity 7.5 Calculation of reflectance/transmittance of test sample 7.6 Assessments of the measurement 7.8 Main error factors 7.9 Main error factors 7.0 Main error factors 7.1 Influence of the instrumental response time on reflectance/transmittance
5.4 High reflectance/transmittance measurement with an optical feedback CRD technique 5.5 Preparation of test sample and measurement arrangement 6.1 Test sample 6.2 Laser source 6.3 Ring-down cavity 7.6.4 Detection unit 7.6.5 Data acquisition and processing 7.6.6 Environment 7.7 Test procedure 7.1 General 7.2 Measurement of decay time of initial cavity 7.3 Calculation of reflectance of cavity mirrors 7.4 Measurement of decay time of test cavity 7.5 Calculation of reflectance/transmittance of test sample 7.6 Assessments of the measurement 7.6 Main error factors 7.1 Influence of the instrumental response time on reflectance/transmittance
6 Preparation of test sample and measurement arrangement 6.1 Test sample. 6.2 Laser source 6.3 Ring-down cavity 7 6.4 Detection unit. 7 6.5 Data acquisition and processing 7 6.6 Environment 7 Test procedure 7.1 General 7.2 Measurement of decay time of initial cavity 7.3 Calculation of reflectance of cavity mirrors 7.4 Measurement of decay time of test cavity 7.5 Calculation of reflectance/transmittance of test sample 7.6 Assessments of the measurement 8 Main error factors 8.1 Influence of the instrumental response time on reflectance/transmittance
6.1 Test sample 6.2 Laser source 6.3 Ring-down cavity 6.4 Detection unit 6.5 Data acquisition and processing 6.6 Environment 7 Test procedure 7.1 General 7.2 Measurement of decay time of initial cavity 7.3 Calculation of reflectance of cavity mirrors 7.4 Measurement of decay time of test cavity 7.5 Calculation of reflectance/transmittance of test sample 7.6 Assessments of the measurement 8 Main error factors 8 Main error factors 10 8 Main error factors 10
6.2 Laser source 6.3 Ring-down cavity 6.4 Detection unit 6.5 Data acquisition and processing 6.6 Environment 7 Test procedure 7.1 General 7.2 Measurement of decay time of initial cavity 7.3 Calculation of reflectance of cavity mirrors 7.4 Measurement of decay time of test cavity 7.5 Calculation of reflectance/transmittance of test sample 7.6 Assessments of the measurement 8 Main error factors 8.1 Influence of the instrumental response time on reflectance/transmittance
6.3 Ring-down cavity
6.4 Detection unit. 6.5 Data acquisition and processing. 6.6 Environment. 7 Test procedure. 7.1 General. 7.2 Measurement of decay time of initial cavity. 7.3 Calculation of reflectance of cavity mirrors. 7.4 Measurement of decay time of test cavity. 7.5 Calculation of reflectance/transmittance of test sample. 7.6 Assessments of the measurement. 8 Main error factors. 8 Main error factors. 10 10 10 10 11 11 11 11 11 1
6.5 Data acquisition and processing 76.6 Environment 8 7 Test procedure 7.1 General 8 7.2 Measurement of decay time of initial cavity 8 7.3 Calculation of reflectance of cavity mirrors 9 7.4 Measurement of decay time of test cavity 7 7.5 Calculation of reflectance/transmittance of test sample 9 7.6 Assessments of the measurement 9 8 Main error factors 10 10 10 10 11 11 11 11 11 11
7 Test procedure 7.1 General 8 7.2 Measurement of decay time of initial cavity 7.3 Calculation of reflectance of cavity mirrors 7.4 Measurement of decay time of test cavity 7.5 Calculation of reflectance/transmittance of test sample 7.6 Assessments of the measurement 7.6 Assessments of the measurement 7.5 Calculation of reflectance/transmittance 7.6 Assessments of the measurement 7.6 Influence of the instrumental response time on reflectance/transmittance 7.5 Influence of the instrumental response time on reflectance/transmittance
7.1 General 8 7.2 Measurement of decay time of initial cavity 8 7.3 Calculation of reflectance of cavity mirrors 9 7.4 Measurement of decay time of test cavity 9 7.5 Calculation of reflectance/transmittance of test sample 9 7.6 Assessments of the measurement 9 8 Main error factors 10 8.1 Influence of the instrumental response time on reflectance/transmittance
7.1 General 8 7.2 Measurement of decay time of initial cavity 8 7.3 Calculation of reflectance of cavity mirrors 9 7.4 Measurement of decay time of test cavity 9 7.5 Calculation of reflectance/transmittance of test sample 9 7.6 Assessments of the measurement 9 8 Main error factors 10 8.1 Influence of the instrumental response time on reflectance/transmittance
7.2 Measurement of decay time of initial cavity
7.3 Calculation of reflectance of cavity mirrors 7.4 Measurement of decay time of test cavity 7.5 Calculation of reflectance/transmittance of test sample 7.6 Assessments of the measurement 8 Main error factors 8.1 Influence of the instrumental response time on reflectance/transmittance
7.5 Calculation of reflectance/transmittance of test sample 7.6 Assessments of the measurement 8 Main error factors 8.1 Influence of the instrumental response time on reflectance/transmittance
7.6 Assessments of the measurement Solution Solu
8 Main error factors 180 13142:2021 100 100 100 100 100 100 100 100 100
8.1 Influence of the instrumental response time on reflectance/transmittance
8.1 Influence of the instrumental response time on reflectance/transmittance
measurement 10
8.1.1 General 10
8.1.2 Multi-parameter fitting method 108.1.3 Data truncation method 11
8.2 Measurement error of the reflectance of cavity mirrors 11
8.3 Measurement error of the reflectance/transmittance of test sample
9 Test report 12
Annex A (informative) Reflectance/transmittance reliability check experiment14
Annex B (informative) Test report
Ribliography 17

Foreword

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The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

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For an explanation on the voluntary nature of standards, the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the World Trade Organization (WTO) principles in the Technical Barriers to Trade (TBT) see the following URL: www.iso.org/iso/foreword.html.

This document was prepared by ISO/TC 172, *Optics and photonics*, Subcommittee SC 9, *Lasers and electro-optical systems*.

This second edition cancels and replaces the first edition ISO 13142:2015, which has been technically revised.

The main changes compared to the previous edition are as follows: 1a-8ba9-07c90748d6aa/iso-13142-2021

addition of transmittance measurements into the document.

Any feedback or questions on this document should be directed to the user's national standards body. A complete listing of these bodies can be found at www.iso.org/members.html.

Introduction

With the development of film-deposition technology, the performance of optical thin films, especially the highly reflective (HR) and highly anti-reflective (AR) coatings which are widely used in large high-power laser systems, interferometric gravitational-wave detectors, laser gyroscopes, and cavity-enhanced and cavity ring-down spectroscopy applications, has been substantially improved in recent years. Laser-based optical systems require some optical components with extremely high reflectance or transmittance characteristic. It is necessary to be able to measure this reflectance or transmittance characteristic precisely. Up to now, the ISO standardized testing methods for reflectance/transmittance of optical laser components have the accuracy limit of approximately 0,01 % (for measurement of absolute reflectance/transmittance), which are not appropriate for measuring the reflectance /transmittance higher than 99,99 %, or in some cases measurement accuracy better than 0,01 % is required. The measurement procedures in this document have been optimized to allow the measurement of high reflectance or transmittance (larger than 99 %, theoretically up to 100 %) of optical laser components using the cavity ring-down technique which provides reflectance or transmittance data with high accuracy, high repeatability and reproducibility, and high reliability.

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Optics and photonics — Lasers and laser-related equipment — Cavity ring-down method for high-reflectance and high-transmittance measurements

1 Scope

This document specifies measurement procedures for the precise determination of the high reflectance or high transmittance (>99 %) of optical laser components.

The methods given in this document are intended to be used for the testing and characterization of high reflectance of both concave and plane mirrors or high transmittance of plane windows used in laser systems and laser-based instruments. The reflectance of convex mirrors or transmittance of positive or negative lenses can also be tested by taking into consideration the radius of curvature of the mirror surface or the focal length of the lens. This document is complementary to ISO 15368 which specifies the measurement procedures for the determination of reflectance and transmittance of optical components with spectrophotometry. ISO 15368 is applicable to the measurements of reflectance and transmittance in the range from 0 % to 100 % with a typical accuracy of ± 0.3 %, and is therefore not applicable to the precise measurements of reflectance and transmittance higher than 99,9 %.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 11145, Optics and photonics — Lasers and laser-related equipment — Vocabulary and symbols

ISO 14644-1, Cleanrooms and associated controlled environments — Part 1: Classification of air cleanliness by particle concentration

ISO 80000-7, Quantities and units — Part 7: Light and radiation

3 Terms and definitions

For the purposes of this document, the terms and definitions given in ISO 11145 and ISO 80000-7 and the following apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- ISO Online browsing platform: available at https://www.iso.org/obp
- IEC Electropedia: available at http://www.electropedia.org/

3.1

reflectance

<for incident radiation of given wavelength, polarization and angle of incidence> ratio of the reflected radiant or luminous flux to the incident flux in the given conditions

3.2

transmittance

<for incident radiation of given wavelength, polarization and angle of incidence> ratio of the transmitted radiant or luminous flux to the incident flux in the given conditions

4 Symbols used and units of measure

Table 1 — Symbols used and units of measure

Symbol	Term	Unit
С	speed of light in measurement environment	m/s
c_0	speed of light in vacuum	m/s
h(t)	impulse response of the ring-down cavity	
$h_0(t)$	Instrumental response function	
L_0	length of the initial cavity	m
L	length of the test cavity	m
ΔL_0	measurement error of the initial cavity length	m
ΔL	measurement error of the test cavity length	m
n	refractive index of air in measurement environment	
R	average reflectance of the concave cavity mirrors, equals square root of $R_1 \times R_2$	
$R_{\rm s}$	reflectance of the test sample	
T_{s}	transmittance of the test sample	
R_1 , R_2	reflectance of two concave cavity mirrors	
R_3	reflectance of the planar cavity mirror	
$ au_{ ext{inst}}$	instrumental response time	S
t	time 11en Standards	S
<i>u</i> (<i>t</i>)	negative-step function	
α	the overall optical loss coefficient (absorption plus scattering) of the gases inside the cavity at the laser wavelength	m ⁻¹
$n_{\rm s}$	refractive index of the transmissive test sample substrate	
d	thickness of the transmissive test sample or central thickness of a lens to be tested	m
$\delta(t)$	delta function ISO 13142:2021	
$ht\theta$ s://s	angle of incidence of the test sample /iso/cellfda4-cl82-431a-8ba9-07c90748d6aa/is	-1 rad 2-1
ρ	radius of curvature of concave surface of the cavity mirror	m
$ au_0$	decay time of the initial cavity	S
τ	decay time of the test cavity	S
$\Delta \tau_0$	measurement error of the decay time of the initial cavity	S
Δau	measurement error of the decay time of the test cavity	S

5 Test principles

5.1 General

The conventional reflectance/transmittance measurement techniques (spectrophotometry and laser ratiometry) are based on measuring the relative changes of light power reflected/transmitted by the test sample. The measurement accuracy is limited by the power fluctuations of the light sources. The cavity ring-down (CRD) technique, on the other hand, is based on the measurement of the decay rate of laser power trapped in a ring-down cavity consisting of at least two highly reflective mirrors. It is therefore totally immune to the power fluctuations of the light sources. The CRD technique can achieve a measurement accuracy that far exceeds the limit set by the power fluctuations of the light sources.

5.2 Decay time of initial cavity and reflectance of cavity mirrors

When a laser beam is coupled into the ring-down cavity, it will gradually leak out of the cavity as a small fraction of the light is transmitted through the cavity mirrors at each reflection. The temporal

behaviour of the cavity output signal immediately after the laser pulse (in the pulsed case, as shown in <u>Figure 1</u>) or immediately after the laser power is switched off [in the continuous wave (cw) case, as shown in <u>Figure 2</u>, or at the falling edge of a square-wave modulated power] can be expressed as an exponentially decay function of time according to the following decay route given in <u>Formula (1)</u>:

$$I(t) \propto I_0 \exp\left(\frac{-t}{\tau_0}\right) \tag{1}$$

Where I_0 is the initial light intensity of the cavity output signal, τ_0 can be expressed as given in Formula (2):

$$\tau_0 = \frac{L_0}{c\left(\alpha L_0 - \ln\sqrt{R_1 R_2}\right)} \tag{2}$$

With Formula (3):

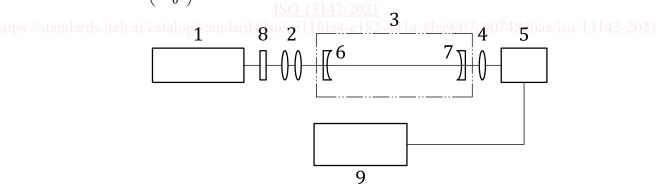
$$c = \frac{c_0}{n} \tag{3}$$

For the case where at test laser wavelength the absorptance and scattering loss of gases inside the ring-down cavity are negligible, the empty cavity ring-down time, τ_0 , is only dependent upon the cavity length and the reflectance of the cavity mirrors and Formula (2) reduces to Formula (4):

$$\tau_0 = \frac{-L_0}{c \ln \sqrt{R_1 R_2}} \qquad \text{iTeh Standards} \tag{4}$$

By experimentally measuring the decay time, τ_0 , the average reflectance of the cavity mirrors can be calculated as Formula (5):



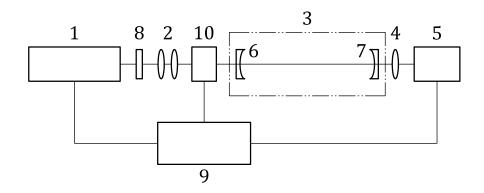


Key

- 1 laser
- 2 mode matching optics
- 3 initial cavity
- 4 focusing lens
- 5 photo-detector

- 6 input cavity mirror, concave high reflectance mirror
- 7 output cavity mirror, concave high reflectance mirror
- 8 polarizer
- 9 control and data-processing unit

Figure 1 — Schematic of optical arrangement for pulsed-CRD technique for high reflectance measurement



Key

- 1 laser
- 2 mode matching optics
- 3 initial cavity
- 4 focusing lens
- 5 photo-detector

- 6 input cavity mirror, concave high reflectance mirror
- 7 output cavity mirror, concave high reflectance mirror
- 8 polarizer
- 9 control and data-processing unit
- 10 optical switch

Figure 2 — Schematic of optical arrangement for cw-CRD technique for high reflectance measurement

5.3 Decay time of test cavity and reflectance/transmittance of test sample

If a reflective/transmissive planar test sample or a lens is to be measured, a test ring-down cavity is formed by inserting this reflective/transmissive test sample or lens into the initial cavity as shown in Figure 3 (for reflective sample) or Figure 4 (for transmissive sample or lens). The incident angle of the laser beam on the test sample follows the required incident angle of the test sample. In case of a lens, the laser beam should propagate through the centre of the lens. In this case, the decay time of the test cavity can be expressed as Formula (6):

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$$\tau = \frac{-L}{c\ln\left(R_{\rm S} \cdot \sqrt{R_1 R_2}\right)} \tag{6}$$

for the reflective sample, and as Formula (7):

$$\tau = \frac{-\left[L + (n_s - 1)d\right]}{c\ln\left(T_s \cdot \sqrt{R_1 R_2}\right)} \tag{7}$$

for the transmissive sample or lens. Therefore, from Formulae (4) and (6), the reflectance, R_s , of the reflective test sample can be calculated as Formula (8):

$$R_{\rm S} = \exp\left(\frac{L_0}{c\tau_0} - \frac{L}{c\tau}\right) \tag{8}$$

And, combining Formulae (4) and (7), the transmittance, T_s , of the transmissive test sample or lens can be calculated as Formula (9):

$$T_{\rm s} = \exp\left[\frac{L_0}{c\tau_0} - \frac{L + (n_{\rm s} - 1)d}{c\tau}\right] \tag{9}$$